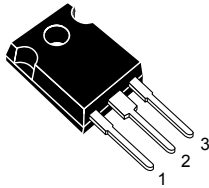
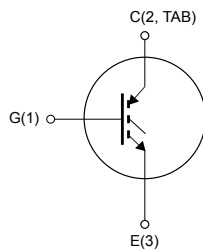


Trench gate field-stop, 600 V, 60 A, very high speed, V series IGBT in a TO-247 package


TO-247


G1C2TE3

Features

- Maximum junction temperature: $T_J = 175\text{ °C}$
- Tail-less switching off
- $V_{CE(sat)} = 1.85\text{ V (typ.) @ } I_C = 60\text{ A}$
- Tight parameter distribution
- Safe paralleling
- Low thermal resistance

Applications

- Photovoltaic inverters
- Uninterruptible power supply
- Welding
- Power factor correction
- Very high frequency converters

Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the V series IGBTs, which represent an optimum compromise between conduction and switching losses to maximize the efficiency of very high frequency converters. Furthermore, the positive $V_{CE(sat)}$ temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Product status link

[STGW60V60F](#)

Product summary

| | |
|-------------------|------------|
| Order code | STGW60V60F |
| Marking | GW60V60F |
| Package | TO-247 |
| Packing | Tube |

1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|--|-------------------|------|
| V_{CES} | Collector-emitter voltage ($V_{GE} = 0$ V) | 600 | V |
| I_C | Continuous collector current at $T_C = 25$ °C | 80 ⁽¹⁾ | A |
| | Continuous collector current at $T_C = 100$ °C | 60 | |
| $I_{CP}^{(2)}$ | Pulsed collector current | 240 | A |
| V_{GE} | Gate-emitter voltage | ±20 | V |
| P_{TOT} | Total dissipation at $T_C = 25$ °C | 375 | W |
| T_{STG} | Storage temperature range | -55 to 150 | °C |
| T_J | Operating junction temperature range | -55 to 175 | °C |

1. Current level is limited by bond wires.

2. Pulse width limited by maximum junction temperature and turn-off within RBSOA

Table 2. Thermal data

| Symbol | Parameter | Value | Unit |
|------------|---------------------------------------|-------|------|
| R_{thJC} | Thermal resistance junction-case IGBT | 0.4 | °C/W |
| R_{thJA} | Thermal resistance junction-ambient | 50 | °C/W |

2 Electrical characteristics

$T_J = 25\text{ °C}$ unless otherwise specified

Table 3. Static characteristics

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--------------------------------------|---|------|------|-----------|---------------|
| $V_{(BR)CES}$ | Collector-emitter breakdown voltage | $V_{GE} = 0\text{ V}$, $I_C = 2\text{ mA}$ | 600 | | | V |
| $V_{CE(sat)}$ | Collector-emitter saturation voltage | $V_{GE} = 15\text{ V}$, $I_C = 60\text{ A}$ | | 1.85 | 2.3 | V |
| | | $V_{GE} = 15\text{ V}$, $I_C = 60\text{ A}$, $T_J = 125\text{ °C}$ | | 2.15 | | |
| | | $V_{GE} = 15\text{ V}$, $I_C = 60\text{ A}$, $T_J = 175\text{ °C}$ | | 2.35 | | |
| $V_{GE(th)}$ | Gate threshold voltage | $V_{CE} = V_{GE}$, $I_C = 1\text{ mA}$ | 5.0 | 6.0 | 7.0 | V |
| I_{CES} | Collector cut-off current | $V_{GE} = 0\text{ V}$, $V_{CE} = 600\text{ V}$ | | | 25 | μA |
| I_{GES} | Gate-emitter leakage current | $V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$ | | | ± 250 | nA |

Table 4. Dynamic characteristics

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--|------|------|------|------|
| C_{ies} | Input capacitance | $V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GE} = 0\text{ V}$ | - | 8000 | - | pF |
| C_{oes} | Output capacitance | | - | 280 | - | pF |
| C_{res} | Reverse transfer capacitance | | - | 170 | - | pF |
| Q_g | Total gate charge | $V_{CC} = 480\text{ V}$, $I_C = 60\text{ A}$, $V_{GE} = 0\text{ to }15\text{ V}$ (see Figure 22. Gate charge test circuit) | - | 334 | - | nC |
| Q_{ge} | Gate-emitter charge | | - | 130 | - | nC |
| Q_{gc} | Gate-collector charge | | - | 58 | - | nC |

Table 5. IGBT switching characteristics (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------|---------------------------|---|------|------|------|------------------|
| $t_{d(on)}^{(1)}$ | Turn-on delay time | $V_{CE} = 400\text{ V}$, $I_C = 60\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GE} = 15\text{ V}$ (see Figure 21. Test circuit for inductive load switching) | - | 60 | - | ns |
| $t_r^{(1)}$ | Current rise time | | - | 20 | - | ns |
| $(di/dt)_{on}^{(1)}$ | Turn-on current slope | | - | 2365 | - | A/ μs |
| $t_{d(off)}$ | Turn-off delay time | | - | 208 | - | ns |
| t_f | Current fall time | | - | 14 | - | ns |
| $E_{on}^{(1)}$ | Turn-on switching energy | | - | 0.75 | - | mJ |
| $E_{off}^{(2)}$ | Turn-off switching energy | | - | 0.55 | - | mJ |
| E_{ts} | Total switching energy | | - | 1.3 | - | mJ |

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------|---------------------------|---|------|------|------|------------------|
| $t_{d(on)}^{(1)}$ | Turn-on delay time | $V_{CE} = 400\text{ V}$, $I_C = 60\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GE} = 15\text{ V}$, $T_J = 175\text{ }^\circ\text{C}$ (see Figure 21. Test circuit for inductive load switching) | - | 57 | - | ns |
| $t_r^{(1)}$ | Current rise time | | - | 23 | - | ns |
| $(di/dt)_{on}^{(1)}$ | Turn-on current slope | | - | 2191 | - | A/ μs |
| $t_{d(off)}$ | Turn-off delay time | | - | 216 | - | ns |
| t_f | Current fall time | | - | 27 | - | ns |
| $E_{on}^{(1)}$ | Turn-on switching energy | | - | 1.5 | - | mJ |
| $E_{off}^{(2)}$ | Turn-off switching energy | | - | 0.8 | - | mJ |
| E_{ts} | Total switching energy | | - | 2.3 | - | mJ |

- Switching-on times and energy have been calculated applying the STGW60V60DF's co-pack diode in the high side of the test circuit shown in [Figure 21. Test circuit for inductive load switching](#). Both the IGBT and the diode are at the same temperature. The turn-on switching energies include the reverse recovery of the diode.
- Including the tail of the collector current.

2.1 Electrical characteristics (curves)

Figure 1. Power dissipation vs case temperature

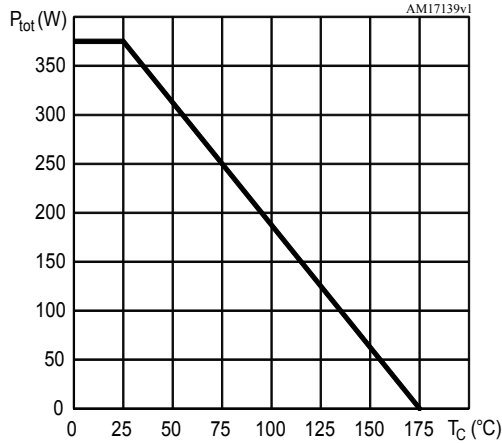


Figure 2. Collector current vs case temperature

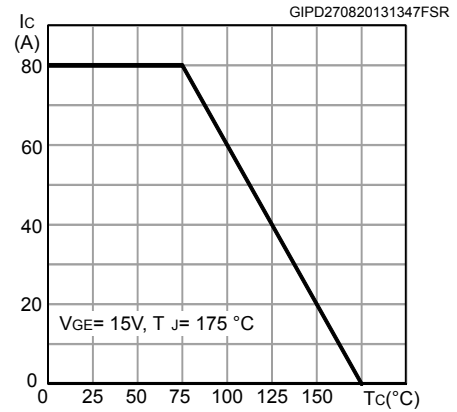


Figure 3. Output characteristics ($T_J = 25^\circ C$)

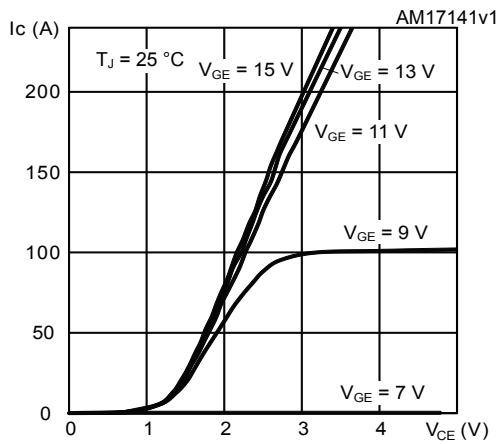


Figure 4. Output characteristics ($T_J = 175^\circ C$)

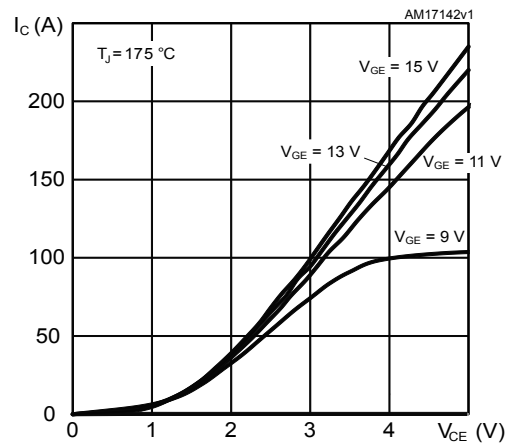


Figure 5. $V_{CE(sat)}$ vs junction temperature

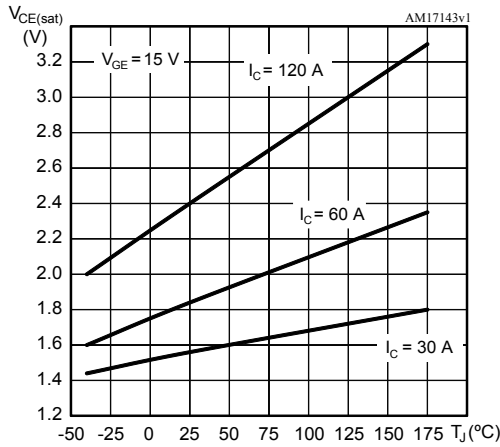


Figure 6. $V_{CE(sat)}$ vs collector current

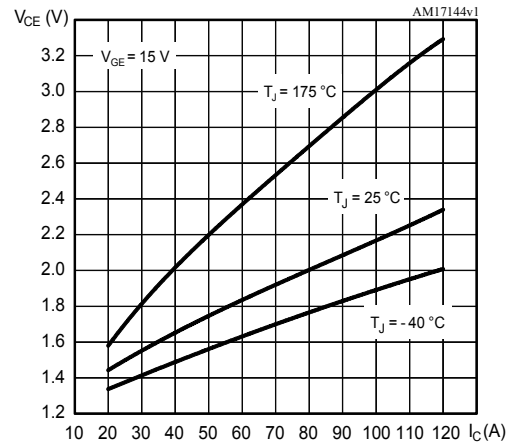


Figure 7. Collector current vs switching frequency

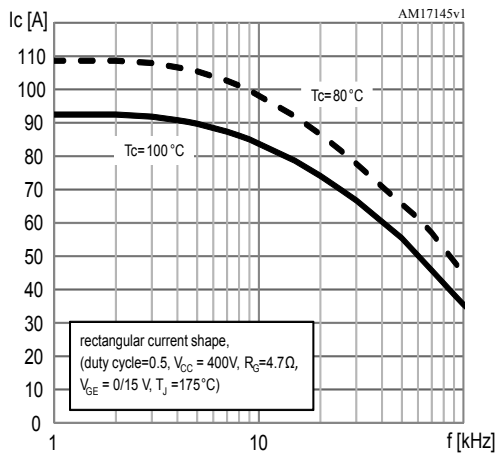


Figure 8. Forward bias safe operating area

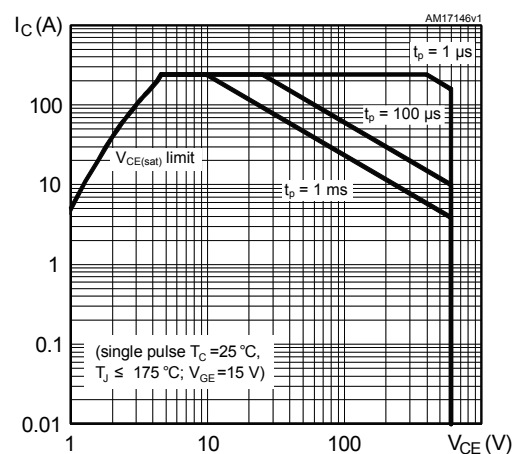


Figure 9. Transfer characteristics

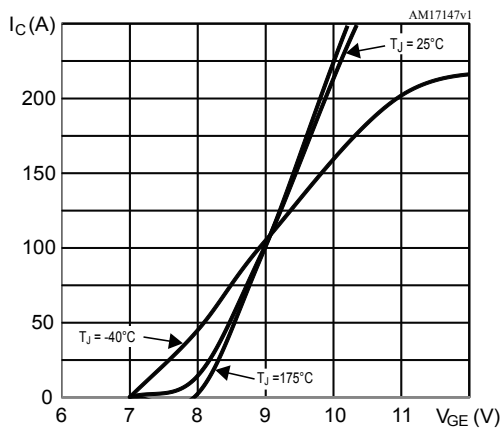


Figure 10. Normalized $V_{GE(th)}$ vs junction temperature

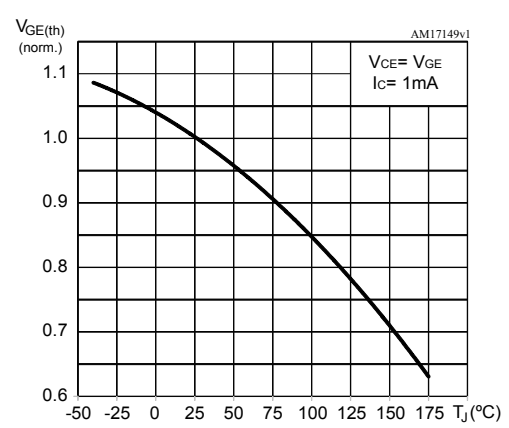


Figure 11. Normalized $V_{(BR)CES}$ vs junction temperature

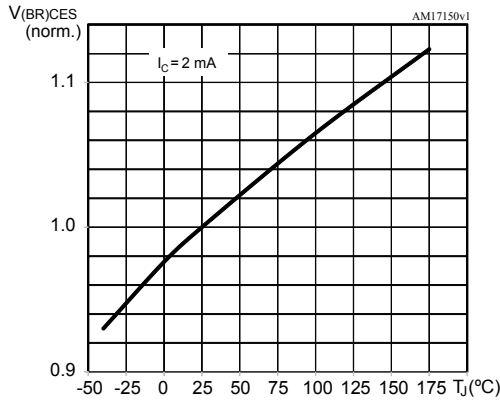


Figure 12. Capacitance variation

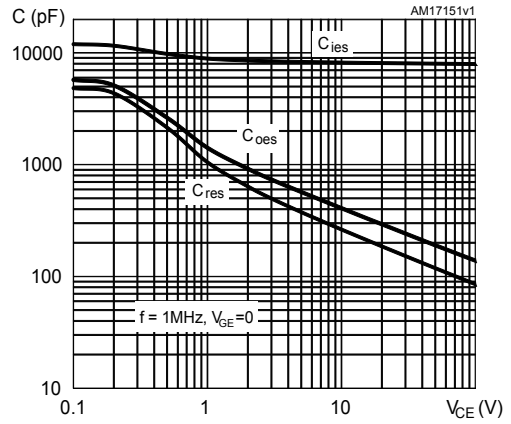


Figure 13. Gate charge vs gate-emitter voltage

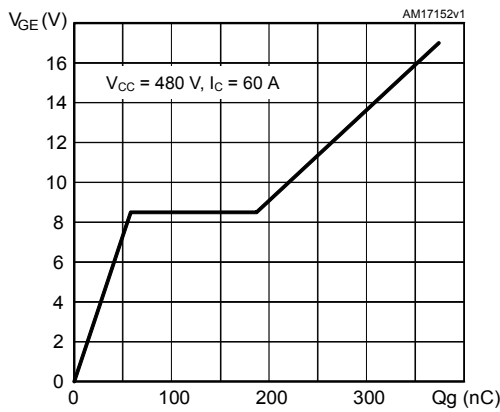


Figure 14. Switching energy vs collector current

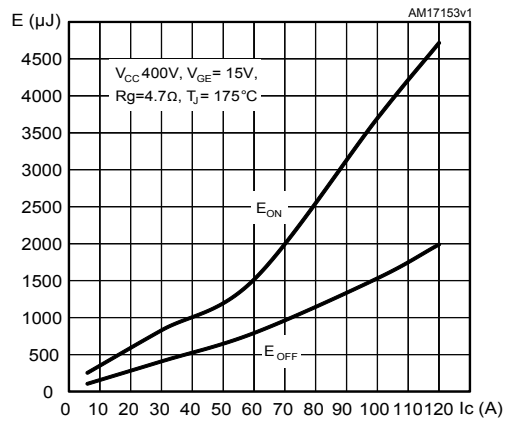


Figure 15. Switching energy vs gate resistance

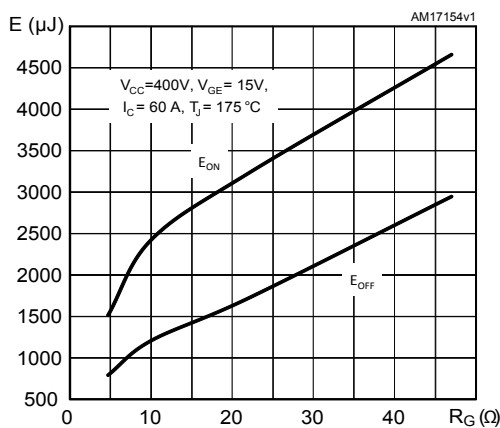


Figure 16. Switching energy vs temperature

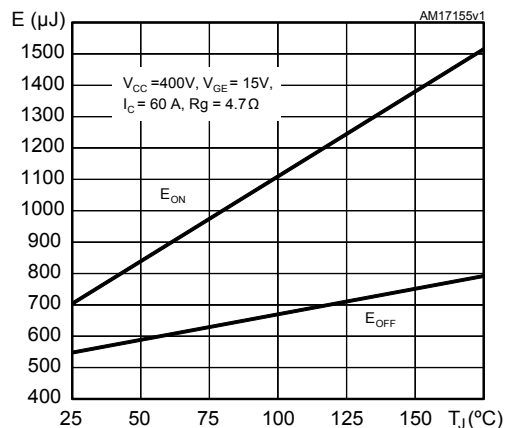


Figure 17. Switching energy vs collector-emitter voltage

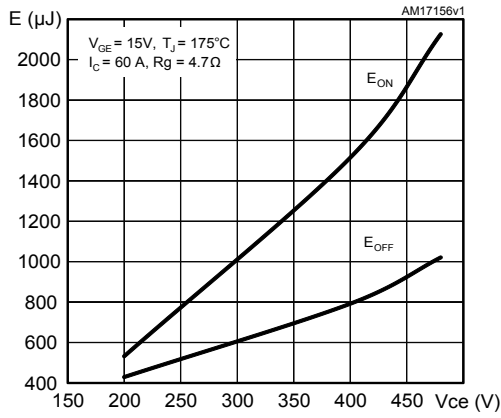


Figure 18. Switching times vs collector current

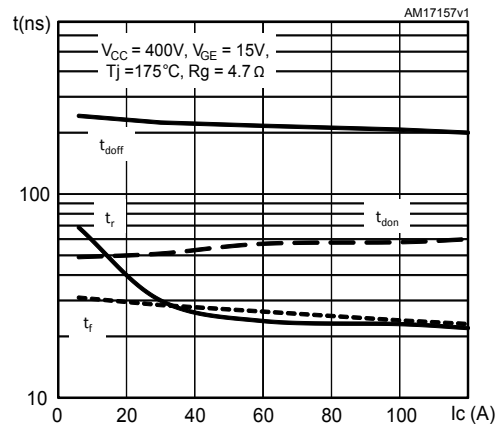


Figure 19. Switching times vs gate resistance

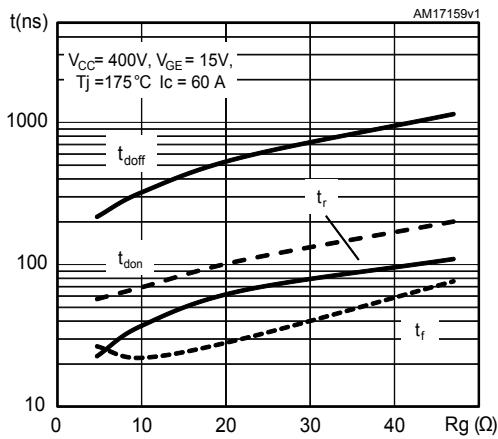
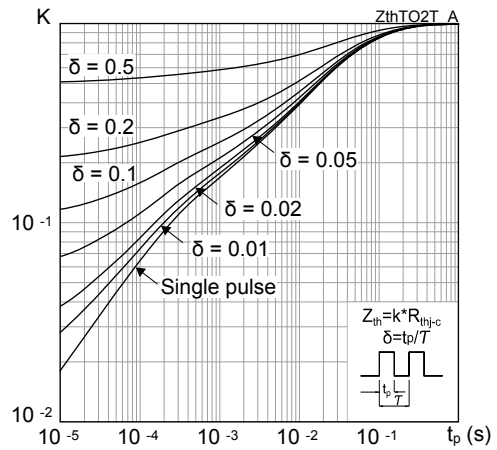
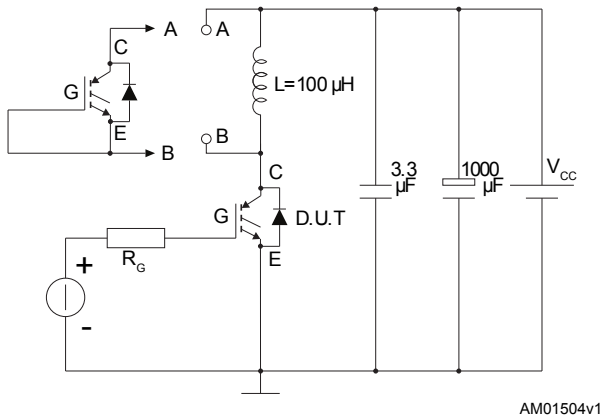
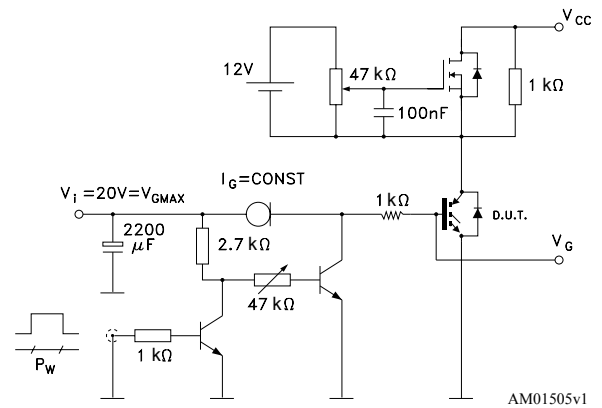
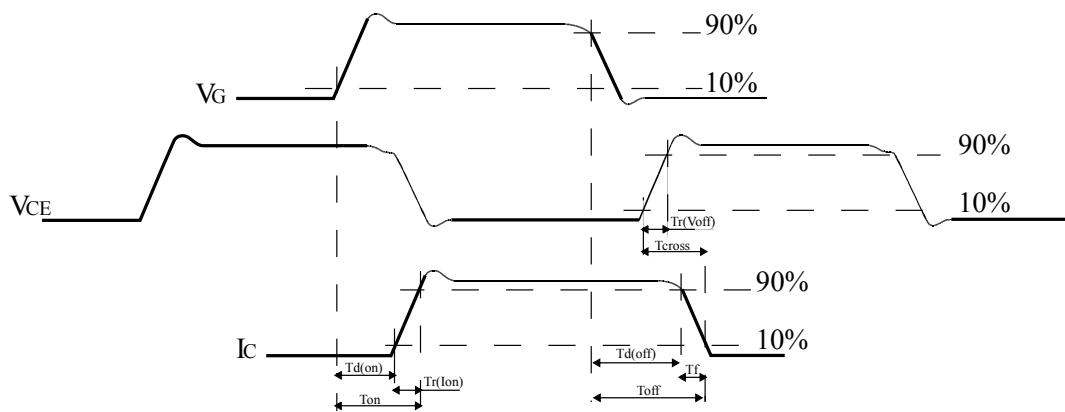


Figure 20. Thermal impedance



3 Test circuits

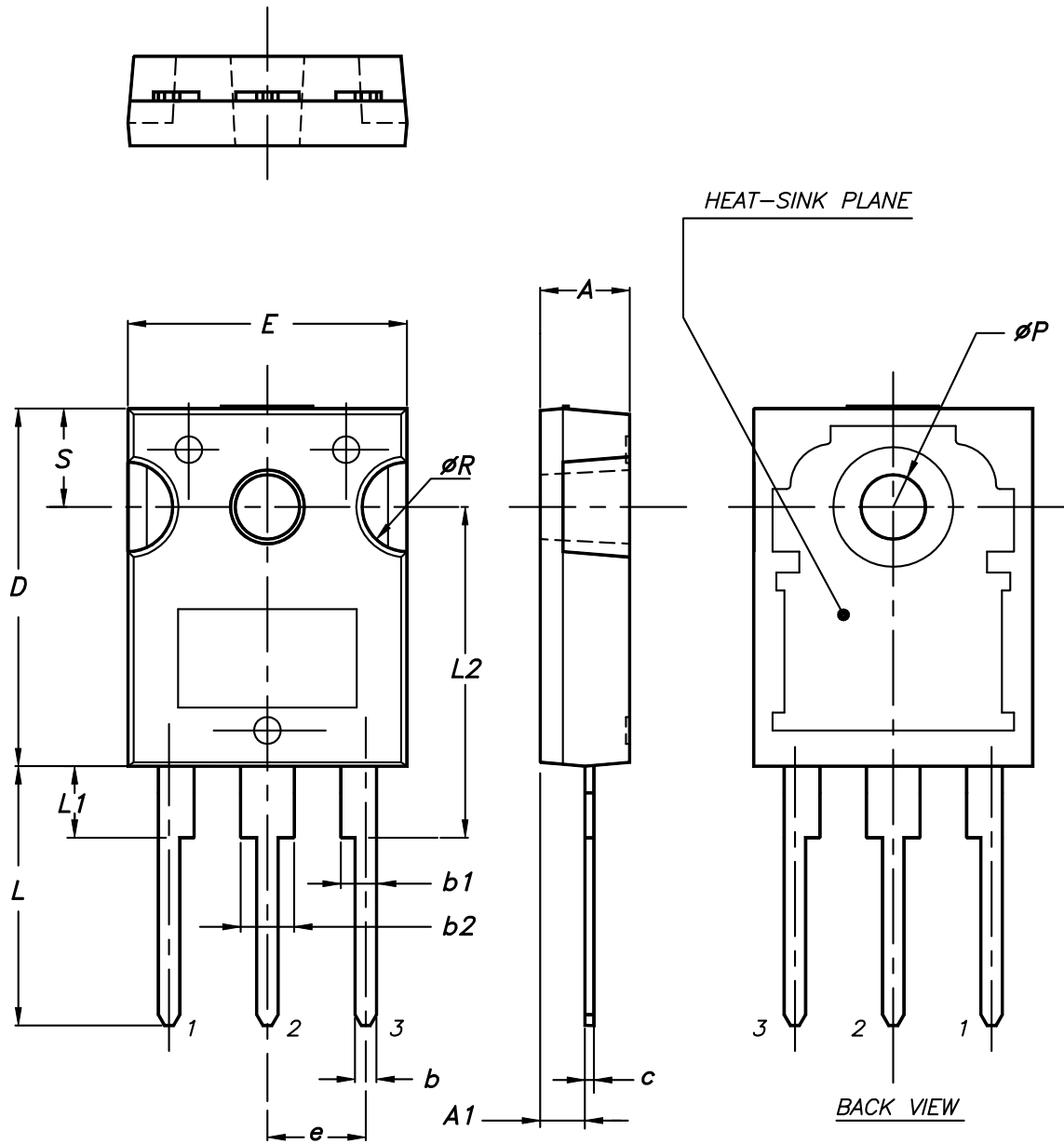
Figure 21. Test circuit for inductive load switching

Figure 22. Gate charge test circuit

Figure 23. Switching waveform


4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 TO-247 package information

Figure 24. TO-247 package outline



0075325_9

Table 6. TO-247 package mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| c | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| e | 5.30 | 5.45 | 5.60 |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| ØP | 3.55 | | 3.65 |
| ØR | 4.50 | | 5.50 |
| S | 5.30 | 5.50 | 5.70 |

Revision history

Table 7. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 04-Jun-2013 | 1 | First release |
| 06-Feb-2014 | 2 | Updated <i>Figure 1: Internal schematic diagram</i> . Updated title, features and description in cover page. Minor text changes. |
| 21-Jun-2017 | 3 | Modified title, features and internal schematic on cover page. Modified <i>Table 3. Static characteristics</i> and <i>Table 5. IGBT switching characteristics (inductive load)</i> . Updated Package information. Minor text changes. |
| 17-Sep-2018 | 4 | Updated Section 2.1 Electrical characteristics (curves) . Minor text changes |

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